# **ON Semiconductor**

## Is Now



To learn more about onsemi™, please visit our website at www.onsemi.com

onsemi and ONSEMI. and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/ or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use onsemi products for any such unintended or unauthorized application,

# **MOSFET** - Power, Single N-Channel, SO8-FL 25 V, 4.2 mΩ, 75 A

# NTMFS4D8N02H

## **Features**

- Advanced Package (5x6 mm) with Excellent Thermal Conduction
- Ultra Low R<sub>DS(on)</sub> to Improve System Efficiency
- Optimized Design to Minimize Conduction and Switching Losses
- These Devices are Pb–Free, Halogen–Free/BFR–Free and are RoHS Compliant

## **Typical Applications**

- High Performance DC-DC Converters
- System Voltage Rails
- Netcom, Telecom
- Servers & Point of Load

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	25	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Current R <sub>0</sub> JC (Note 1)	Steady	T <sub>C</sub> = 25°C	I <sub>D</sub>	75	Α
Power Dissipation $R_{\theta JC}$ (Note 1)	State	T <sub>C</sub> = 25°C	P <sub>D</sub>	41	W
Continuous Drain Current R <sub>0JA</sub> (Note 1)	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	21	Α
Power Dissipation $R_{\theta JA}$ (Note 1)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	3.2	W
Pulsed Drain Current	$T_A = 25$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	216	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 32 A, L = 0.1 mH) (Note 2)			E <sub>AS</sub>	51	mJ
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 1)	$R_{ heta JC}$	3.7	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	47.3	

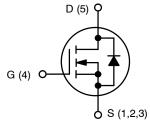
- 1. Surface-mounted on FR4 board using a 1 in<sup>2</sup>, 2 oz. Cu pad.
- 2. This is the absolute maximum rating. Parts are 100% UIS tested at  $T_J$  = 25°C,  $V_{GS}$  = 10 V,  $I_L$  = 21 A,  $E_{AS}$  = 22 mJ.



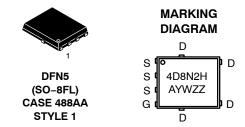
## ON Semiconductor®

## www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
OF V	4.2 mΩ @ 10 V	75 A
25 V	7.0 mΩ @ 4.5 V	75 A



**N-CHANNEL MOSFET** 



4D8N2H = Specific Device Code

A = Assembly Location
V - Year

Y = Year
W = Work Week
ZZ = Lot Traceability

## **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 5 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

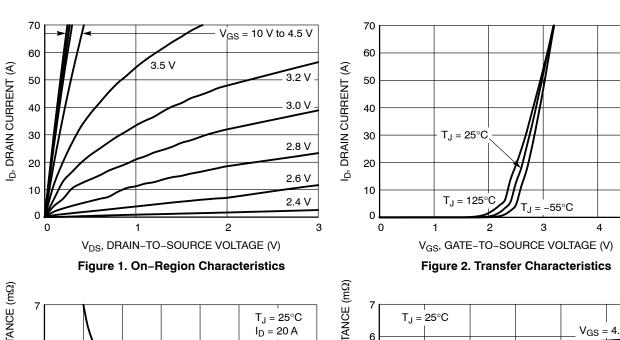
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		25			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /	$I_D = 250 \mu A$ , ref to 25°C			10.6		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$ ,	T <sub>J</sub> = 25°C			1.0	μΑ
		V <sub>DS</sub> = 20 V	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	= 20 V			100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μA	1.2		2.1	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA, ref to 25°C			-4.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 20 A		3.4	4.2	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 15 A		5.4	7.0	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 15 A			54		S
Gate Resistance	$R_{G}$	T <sub>A</sub> = 25°	С		0.9		Ω
CHARGES & CAPACITANCES							•
Input Capacitance	C <sub>ISS</sub>				780		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 12	. V, f = 1 MHz		530		
Reverse Transfer Capacitance	C <sub>RSS</sub>	GG . DG ,			39		1
Total Gate Charge	Q <sub>G(TOT)</sub>				6.2		
Threshold Gate Charge	Q <sub>G(TH)</sub>				1.4		
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 12 \text{ V}; I_D = 30 \text{ A}$			2.5		nC
Gate-to-Drain Charge	$Q_{GD}$				1.5		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 12 V; I <sub>D</sub> = 30 A			13.4		nC
SWITCHING CHARACTERISTICS, V <sub>GS</sub> = 4	.5 V (Note 4)						
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 12 V, $I_{D}$ = 30 A, $R_{G}$ = 3 $\Omega$			9.7		- ns
Rise Time	t <sub>r</sub>				7.4		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				13		
Fall Time	t <sub>f</sub>				5.2		1
SWITCHING CHARACTERISTICS, V <sub>GS</sub> = 1	<b>0 V</b> (Note 4)						
Turn-On Delay Time	t <sub>d(ON)</sub>				6.9		
Rise Time	t <sub>r</sub>	Voo = 10 V Voo	s – 12 V		2.6		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 12 V, $I_D$ = 30 A, $R_G$ = 3 $\Omega$			18		ns
Fall Time	t <sub>f</sub>				2.7		
DRAIN-SOURCE DIODE CHARACTERIST	ICS						1
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.8	1.0	- v
		$I_S = 10 \text{ A}$	T <sub>J</sub> = 125°C		0.65		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 10 \text{ A}$			28		
Charge Time	ta				14		ns
Discharge Time	t <sub>b</sub>				14	<del>                                     </del>	
Reverse Recovery Charge	Q <sub>RR</sub>				11		nC
, ,	9.03				<u> </u>		<u> </u>

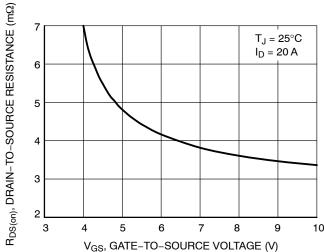
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

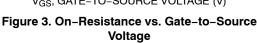
3. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

4. Switching characteristics are independent of operating junction temperatures.

## **TYPICAL CHARACTERISTICS**







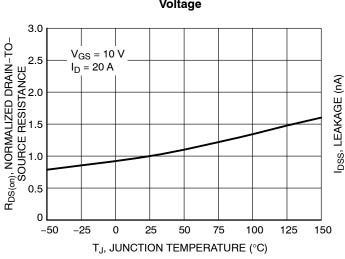
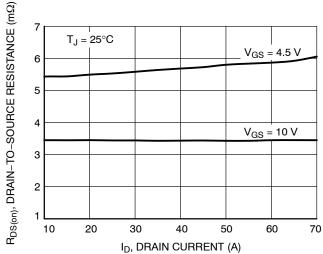


Figure 5. On-Resistance Variation with Temperature



5

Figure 4. On-Resistance vs. Drain Current and Gate Voltage

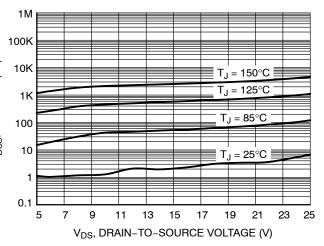


Figure 6. Drain-to-Source Leakage Current vs. Voltage

## **TYPICAL CHARACTERISTICS**

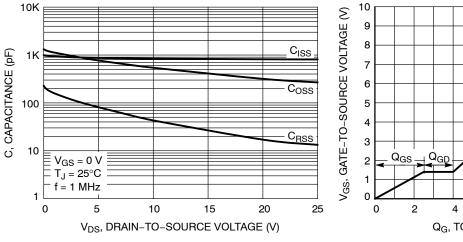


Figure 7. Capacitance Variation

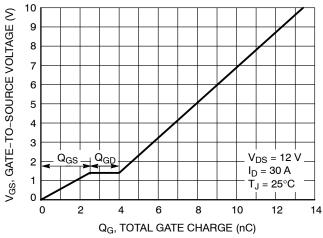


Figure 8. Gate-to-Source vs. Total Charge

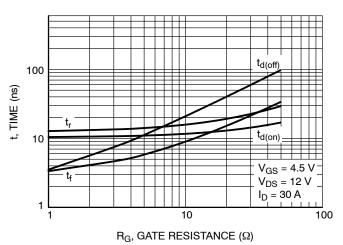


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

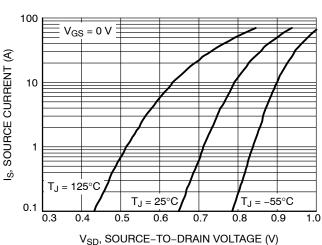


Figure 10. Diode Forward Voltage vs. Current

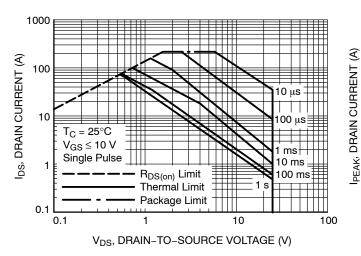


Figure 11. Maximum Rated Forward Biased Safe Operating Area

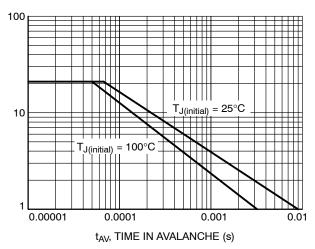


Figure 12. Maximum Drain Current vs. Time in Avalanche

## **TYPICAL CHARACTERISTICS**

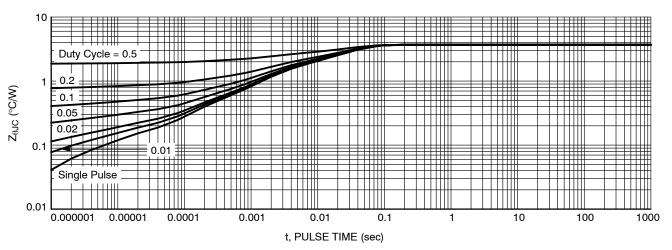


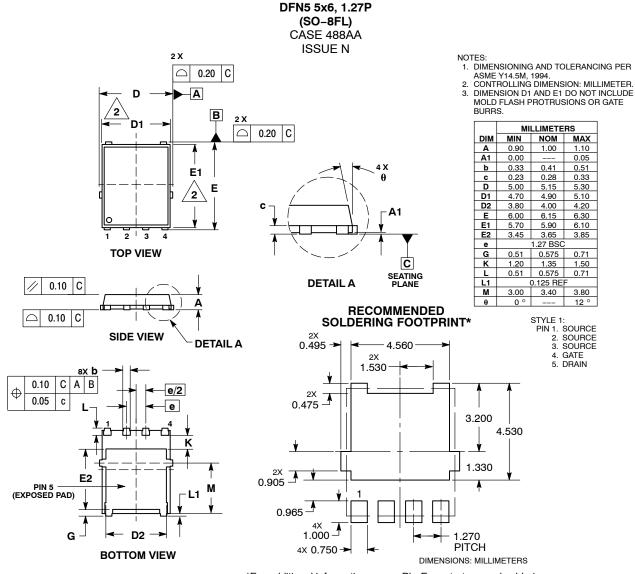
Figure 13. Transient Thermal Impedance

## **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NTMFS4D8N02HT1G	4D8N2H	DFN5 (Pb-Free)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### PACKAGE DIMENSIONS



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and ware trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <a href="https://www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. ON Semiconductor reserves the right to make changes without further notice to any products perein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify a

#### **PUBLICATION ORDERING INFORMATION**

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

ON Semiconductor Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative